



QuickPRO-CUBE[™] Mini

High-Speed, dual-surface, geometry characterization of single or in-tray optical components

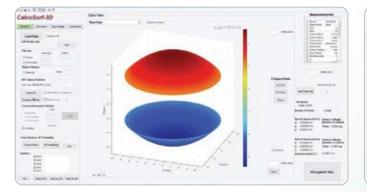
By integrating a pair of single-point, non-contact, nanometer-resolution chromatic confocal sensors with high-speed, nanometer-encoded X/Y/Z coordinated motion, the QuickPRO-CUBE™ captures front, back and datum surface 3D point cloud topography for the geometric characterization of single lenses or micro lenses in trays. The form invariant motion architecture permits measurement of both rotationally symmetric and more complex non-axially symmetric or freeform shapes to a maximum measurement diameter of 50mm. The total measurement time is from 30sec to 60sec per surface per lens, depending on the lens diameter and 3D point cloud sampling density.

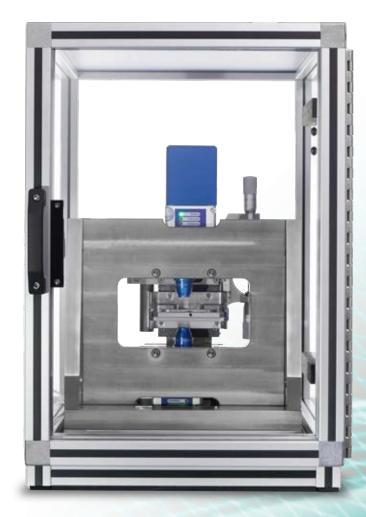
Measured geometric parameters include:

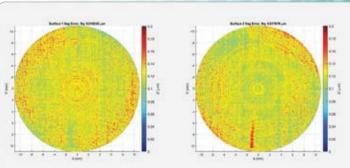
- Front-to-Back surface Vertex Offset relative to defined centration
- Front-to-Back surface Wedge Angle relative to defined tilt datum
- Front-to-Back Total Thickness variation (TTV)
- Front and Back surface Sag/Form error

Applications

The CUBE is specifically designed for factory-floor QA of polished, molded, or diamond turned optical components, including optically opaque infrared lens materials and metals. An added advantage is the ability to measure multiple smaller lenses in-tray or lens arrays during a single measurement sequence.







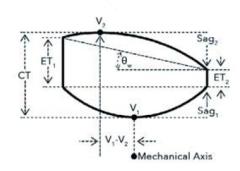


System Characteristics

- Compact, bench-top unit with environmental enclosure.
- Dual single-point, non-contact, visible-light, chromatic confocal sensors with up to 10kHz combined measuring rate.
- Vibration insensitive and dimensionally stable Invar metrology frame.
- Nanometer encoded X/Y/Z coordinated motion with magnetic linear motors and cross roller bearings for fast raster, spiral or custom-scanning over 50mm (X), 50mm M, 50mm (Z).
- Self-centering fixture with precision quick connect for fast load/unload.
- Fixtures for both single optical components and micro-lens trays.
- User-friendly QuickPRO[™] instrument control and data acquisition software for sensor optimization, auto-centering, data capture and coordinated motion sequencing.
- CalcuSurf-3D[™] view and analyze software for multi-surface 3D point cloud data.

Geometric Parameters

- Vertex-to-Vertex Offset (V1-V2)
- Wedge Angle (0_W)
- Center Thickness (CT)
- Edge Thickness Variation (ET1-ET2)
- Radius of Curvature (R₁ & R₂)
- Sag (Sag₁ & Sag₂)



QuickPRO-CUBE[™]Mini

| SYSTEM | | | |
|----------------------------|--|-----------------------------|-------|
| Dimensions (L: W: H) | 560mm x 560mm x 370mm | | |
| Weight | 60kg | | |
| System Controller | Motion and sensor control; high-speed data link | | |
| Power Requirements | 110-220V AC, 50-60 Hz, 2 amps (220V), 5 amps (110V) | | |
| MOTION | | | |
| Measurement Area (X: Y: Z) | 50mm x 50mm x 30mm | | |
| Position Accuracy | < 1µm | | |
| Drive Type | Linear servo motor w/magnetic counterbalance (Z) | | |
| Stage Speed | 100mm/s | | |
| Scan Type/Path | Spiral, Raster, User-Defined | | |
| Max Sample Size | Ø75mm | | |
| Load Capacity | 2kg | | |
| SENSORS | | | |
| Technique | Chromatic Confocal x2 | | |
| Applications | Distance, Centration, Wedge, Sag, Thickness | | |
| Sampling | Up to 10,000 points/sec/sensor | | |
| Probe Range | 0.4mm | 0.5mm (HS) | 1mm |
| Lateral Resolution | 2µm | 5µm | 4µm |
| Working Distance | 15mm | 11mm | 37mm |
| Axial Resolution | 3nm | 20nm | 150nm |
| Maximum Slope | ±45° | > ±45° | ±45° |
| MEASUREMENTS | | | |
| V1-V2 Decenter Accuracy | 0.010mm | Includes edge run-out | |
| Wedge Accuracy | 0.005° [18 arcsec] | Requires datum surfaces | |
| Axial Measurement Accuracy | 0.001mm | | |
| Thickness Accuracy (TTV) | 0.002mm | Depends on refractive index | |

*Dependent on sample quality and 3D point cloud density

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